

Application/Control No.	Applicant(s)/Patent under Reexamination
10/640,346	WANG, JIAN CHUNG
Examiner	Art Unit
Andre Pierre-Louis	2123

	SEARCHED					
Class	Subclass	Date	Examiner			
703	21,22	4/20/2006	APL			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (EAST (US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT;IBM_TDB)- SEE ATTACHMENT	4/20/2006	APL
709/223 (Text Search Only_See search history printout)	4/20/2006	APL
714/4–43 (Text Search Only_See search history printout)	4/20/2006	APL